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Title: Detecting and Explaining Self-Admitted Technical Debts with Attention- based Neural Networks

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Book Group Author(s): IEEE Comp Soc

Source: 2020 35TH IEEE/ACM INTERNATIONAL CONFERENCE ON AUTOMATED SOFTWARE ENGINEERING (ASE 2020) Book Series: IEEE ACM

International Conference on Automated Software Engineering Pages: 871-882 DOI: 10.1145/3324884.3416583 Published: 2020

Accession Number: WOS:000651313500073

Conference Title: 35th IEEE/ACM International Conference on Automated Software Engineering (ASE)

Conference Date: SEP 21-25, 2020

Conference Location: ELECTR NETWORK

Conference Sponsors: IEEE, Assoc Comp Machinery, IEEE Comp Soc, Monash Univ, NASA Ames Rese Ctr, IEEE Tech Council Software Engn, ACM SIGAI, ACM

Special Interest Grp Software Engn, Deakin Univ

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ISSN: 1527-1366

ISBN: 978-1-4503-6768-4

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